Search Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/700,094	CHEN ET AL.	
Examiner	Art Unit	
Ankur Gogia	2187	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PLUS	12/9/2005	1.4
EAST (All Databases)	12/12/2005 (mplured 213/05 12/91-23/05 12/9-11/061	IN.
711/4 (text search only see attached search history)	12/12/2005	<i>f.1</i> 1.
Inventor Search (Palm and EAST)	1/9/2006	<i>‡.</i> ,/.
EIC Fast and Focused Search	12/13/2005	1.h